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Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/739,351	TAKAHASHI ET AL.	
Examiner	Art Unit	<del>-</del>
Jeffrie R. Lund	1763	

	SEARCHED		
Class	Subclass	Date	Examiner
118	715		
156	345.29	3/17/2006	JRL
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
COMPUTER SEARCH – SEE ATTACHED SEARCH HISTORY	3/17/2006	JRL